Schedule of Accreditation

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Accredited to ISO/IEC 17025:2005

Poole Instrument Calibration Limited

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Calibration performed by the Organisations at the locations specified below

Locations covered by the organisation and their relevant activities

Laboratory locations:

Location details	Activity	Location code
Address Unit 1 Cabot Business Village Holyrood Close Poole Dorset BH17 7BA **Local contact** Mr Matthew Suter Tel: +44 (0)1202 658333 Fax: +44 (0)1202 659966 Email: m.suter@pooleinstruments.com	Electrical and Temperature.	P

Site activities performed away from the locations listed above:

Location details	Activity	Location code
The customers' site or premises must be suitable for the nature of the particular calibrations undertaken and will be the subject of contract review arrangements between the laboratory and the customer.	Electrical and Temperature.	S

DETAIL OF ACCREDITATION

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
ELECTRICAL				
DC Voltage				
Measurement	0 mV to 200 mV 200 mV to 2 V 2 V to 20 V 20 V to 200 V 200 V to 1 kV	5.0 μV 20 μV 0.11 mV 1.0 mV 20 mV		P
Generation	0 mV to 200 mV 200 mV to 2 V 2 V to 20 V 20 V to 200 V 200 V to 1000 V	7.0 μV 15 μV 0.40 mV 5.0 mV 10 mV		P
DC Current				
Measurement	0 μA to 200 μA 200 μA to 2 mA 2 mA to 20 mA 20 mA to 200 mA 200 mA to 2 A	0.020 μA 0.10 μA 1.0 μA 10 μA 0.25 mA		P
Generation	0 μA to 200 μA 200 μA to 2 mA 2 mA to 20 mA 20 mA to 200 mA 200 mA to 2 A 2 A to 30 A	0.040 μA 0.20 μA 1.0 μA 15 μA 0.25 mA 7 mA		P
	0 A to 60 A 60 A to 300 A 300 A to 1500 A	100 mA 160 mA 650 mA	Simulated current using multi turn coil, for the calibration of clamp-on ammeters.	P
DC Resistance				
Measurement	0 Ω to 20 Ω 20 Ω to 200 Ω 200 Ω to 2 kΩ 2 kΩ to 20 kΩ 20 kΩ to 200 kΩ 200 kΩ to 2 MΩ 2 MΩ to 20 MΩ 20 MΩ to 200 MΩ 200 MΩ to 1 GΩ	0.50 mΩ 2.0 mΩ 20 mΩ 0.20 Ω 2.0 Ω 20 Ω 1.0 kΩ 120 kΩ 2.5 MΩ		P

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
DC Resistance (cont'd)				
Generation (2 wire)	0.2 Ω 0.3 Ω 1 Ω 10 Ω 100 Ω 1 kΩ 10 kΩ 100 kΩ 1 MΩ 10 MΩ 100 MΩ 1 GΩ	0.010 Ω 0.02 Ω 0.015 Ω 0.020 Ω 0.015 Ω 0.020 Ω 0.06 Ω 4.0 Ω 0.02 kΩ 2.1 kΩ 0.03 MΩ 5.5 MΩ	Nominal values	P
Generation (4 wire)	100 mΩ 1 Ω 10 Ω 100 Ω 1 kΩ 10 kΩ 100 kΩ	2.0 mΩ 2.0 mΩ 2.0 mΩ 4.5 mΩ 0.015 Ω 0.03 Ω 1.0 Ω	Nominal values	P
AC Voltage				
Measurement	*40 Hz to 1 kHz* 2 mV to 200 mV 200 mV to 2V 2 V to 20 V 20 V to 200 V *1 kHz to 60 kHz* 2 mV to 200 mV 200 mV to 2V 2 V to 20 V 20 V to 200 V *45 Hz to 30 kHz* 200 V to 1 kV	 15 μV 150 μV 1.0 mV 10 mV 50 μV 0.50 mV 4.0 mV 0.040 V 1.4 V		P
Generation	0 mV to 20 mV *40 Hz to 206 Hz* 20 mV to 200 mV *10 Hz to 100 kHz* 200 mV to 2 V *10 Hz to 100 kHz* 2 V to 20 V *40 Hz to 20 kHz* 20 V to 200 V *40 Hz to 20 kHz*	0.070 mV 0.30 mV 2.0 mV 0.050 V 0.35 V		P

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
AC Voltage (cont'd)				
Generation (cont'd)	200 V to 700 V *40 Hz to 10 kHz*	0.8 V		P
	700 V to 1000 V *56 Hz*	0.70 V		
AC Current Measurement	*40 Hz to 3 kHz*			P
	0 μA to 200 μA	0.10 μA		
	200 μA to 2 mA 40 Hz to 5 kHz	0.50 μA		
	2 mA to 20 mA	5.0 μA		
	20 mA to 200 mA	0.050 mA		
	200 mA to 2 A	2.0 mA		
Generation	*40 Hz to 206 Hz*			P
	0 μA to 25 μA	0.35 μA		
	40 Hz to 1 kHz			
	25 μA to 200 μA	0.50 μA		
	200 μA to 2 mA	3.5 μA		
	2 mA to 20 mA	0.030 mA		
	20 mA to 200 mA	0.30 mA		
	200 mA to 2 A	3.5 mA		
	40 Hz to 100 Hz			
	2 A to 20 A	0.012 A		
	56 Hz			
	2 A to 30 A	0.018 A		
	50 Hz			
	0 A to 60 A	100 mA	Simulated current using multi turn coil, for the calibration of clamp-on ammeters.	
	60 A to 300 A	270 mA		
	300 A to 1500 A	1.2 A		
Capacitance				
Generation	1 nF	3.0 pF	Nominal values	P
	10 nF	20 pF		
	20 nF	35.0 pF		
	50 nF	0.010 nF		
	100 nF	0.015 nF		
	1 μF	5.0 nF		
	10 μF	0.25 nF		
Frequency				
Generation	10 Hz to 100 Hz	0.0010 Hz		P
	100 Hz to 1 kHz	0.005 Hz		
	1 kHz to 10 kHz	0.05 Hz		
	10 kHz to 20 kHz	0.10 Hz		
	20 kHz to 50 kHz	0.25 Hz		
	50 kHz to 100 kHz	0.50 Hz		
	100 kHz to 1 MHz	0.005 kHz		
	1 MHz to 10 MHz	0.05 kHz		

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
TEMPERATURE SIMULATION				
Temperature indicators, calibration by electrical simulation, for the following sensor types:				
Noble metal thermocouples			with cold junction Compensation	P
Type R	0 °C to 1700 °C	0.50 °C		
Type S	-50 °C to +1700 °C	0.50 °C		
Base metal thermocouples			with cold junction Compensation	P
Type K	-140 °C to +1340 °C	0.30 °C		
Type J	-150 °C to +750 °C	0.30 °C		
Type T	-250 °C to +400 °C	0.40 °C		
Type N	-150 °C to +1300 °C	0.30 °C		
Type E	0 °C to 800 °C	0.32 °C		
Resistance thermometer (Pt100)	-100 °C	0.050 °C	Nominal values	P
	0 °C	0.030 °C		
	30 °C	0.040 °C		
	60 °C	0.050 °C		
	100 °C	0.050 °C		
	200 °C	0.060 °C		
	400 °C	0.070 °C		
	800 °C	0.080 °C		
Base metal thermocouples			with cold junction Compensation	S
Type K	-50 °C to +1300 °C	0.71 °C		
Type J	-50 °C to +1100 °C	0.60 °C		
Type T	-50 °C to +390 °C	0.76 °C		
Type N	-50 °C to +1300 °C	0.93 °C		
Resistance thermometer (Pt100)	-50 °C to +600 °C	0.28 °C		S
Temperature simulators, calibration by electrical simulation, for the following sensor types:				
Noble metal thermocouples			with cold junction Compensation	P
Type R	0 °C to 1600 °C	0.70 °C		
Type S	0 °C to 1600 °C	0.70 °C		

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
Base metal thermocouples			with cold junction Compensation	P
Type K	-150 °C to +555 °C 555 °C to 1300 °C	0.50 °C 0.50 °C		
Type J	-150 °C to +1100 °C	0.50 °C		
Type T	-150 °C to +100 °C 100 °C to 390 °C	0.50 °C 0.50 °C		
Type N	-150 °C to +1250 °C	0.50 °C		
Type E	-150 °C to +355 °C 355 °C to 900 °C	0.60 °C 0.40 °C		
Resistance thermometer	-200 °C to 0 °C 0 °C to 800 °C	0.010 °C 0.020 °C		P
Base metal thermocouples			with cold junction Compensation	S
Type K	-50 °C to 0 °C 0 °C to 1300 °C	1.0 °C 1.0 °C		
Type J	-50 °C to +750 °C	1.0 °C		
Type T	-50 °C to 0 °C 0 °C to 390 °C	1.1 °C 1.0 °C		
Type N	-50 °C to +1300 °C	1.0 °C		
Resistance thermometer (Pt100)	-50 °C to +600 °C	0.24 °C		S
TEMPERATURE				
Resistance thermometers and Electronic thermometers with sensors	-30 °C to +140 °C 0.01 °C	0.10 °C 0.035 °C	In Triple point of water cell	P
	140 °C to 400 °C 400 °C to 600 °C	0.15 °C 0.18°C		
Base metal thermocouples	-30 °C to 200 °C	0.40 °C		P
	200 °C to 600 °C	0.6 °C		
Noble metal thermocouples				
Type R & Type S	0 °C to 200 °C 200 °C to 400 °C 400 °C to 600 °C	0.60 °C 0.75 °C 1.0 °C		
Metal block calibrators	-40 °C to +30 °C	0.045 °C		P
	30 °C to 230 °C 230 °C to 420 °C 420 °C to 660 °C	0.05 °C 0.06 °C 0.085 °C		

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
Temperature surveys				
Temperature controlled, incubators, ovens, environmental chambers, fridges/refrigerators and freezers	-75 °C to +200 °C 200 °C to 600 °C	0.75 °C 1.0 °C	Single and multipoint time dependent temperature profiling, also referred to as spatial temperature surveying or mapping	S
Temperature indicators and recorders, with temperature sensor(s)	-30 °C to +140 °C 140 °C to 400 °C 200 °C to 400 °C 400 °C to 600 °C	0.16 °C 0.20 °C 0.25 °C 0.30 °C		S
EQUIPMENT FOR IEE 16TH/17TH/18TH EDITION WIRING TESTING				
LOOP TESTERS				
	Nominal applied resistances			
AC Resistance at 50 Hz	0.05 Ω 0.10 Ω 0.22 Ω 0.33 Ω 0.5 Ω 1 Ω 5 Ω 10 Ω 100 Ω 1 kΩ	3.6 mΩ 3.9 mΩ 3.6 mΩ 4.1 mΩ 4.9 mΩ 6.6 mΩ 20 mΩ 37 mΩ 370 mΩ 3.0 Ω		P
CONTINUITY TESTERS				
DC Resistance	1 mΩ to 100 mΩ 100 mΩ to 2 Ω 2 Ω to 100 Ω 100 Ω to 1 kΩ 1 kΩ to 10 kΩ 10 kΩ to 50 kΩ	1.0 mΩ 2.0 mΩ 3.8 mΩ 14 mΩ 32 mΩ 2.0 Ω		P
Continuity Current Measurement	0 mA to 400 mA	70 uA		P

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
INSULATION TESTERS				
DC Resistance	10 kΩ to 20 kΩ 20 kΩ to 2 MΩ 2 MΩ to 4 MΩ 4 MΩ to 6 MΩ 6 MΩ to 9 MΩ 9 MΩ to 20 MΩ 20 MΩ to 90 MΩ 90 MΩ to 400 MΩ 400 MΩ to 800 MΩ 800 MΩ to 2 GΩ 2 GΩ to 10 GΩ	0.12 % 0.12% 0.12 % 0.12 % 0.60 % 0.85 % 0.65 % 1.3 % 1.2 % 1.30 % 3.0 %		P
DC Voltage	50 V 100 V 150 V 200 V 250 V 500 V 1000 V	0.80 V 1.1 V 1.4 V 1.7 V 2.0 V 3.5 V 6.5 V		P
Earth Resistance	100 mΩ to 2 Ω 2 Ω to 100 Ω 100 Ω to 1 kΩ	2.0 mΩ 3.8 mΩ 14 mΩ		P
RCD TESTERS				
Trip time	20 ms to 390 ms 390 ms to 1 s	0.75 ms 9.3 ms		P
Trip Current at 50 Hz	10 mA 15 mA 30 mA 60 mA 100 mA 150 mA 300 mA 500 mA 1 A	110 µA 170 µA 280 µA 520 µA 770 µA 1.2 mA 2.4 mA 4.0 mA 8.0 mA		P
AC Voltage Source at 50 Hz	100 V 200 V 230 V 300 V 400 V	0.27 V 0.36 V 0.48 V 0.48 V 0.66 V		P

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks	Location Code
PORTABLE APPLIANCE TESTERS				
Earth Bond Resistance at 50Hz	0.05 Ω 0.1 Ω 0.17 Ω 0.28 Ω 0.38 Ω 0.54 Ω 1 Ω 5 Ω 10 Ω 100 Ω 1 kΩ	3.5 mΩ 5.0 mΩ 5.5 mΩ 5.5 mΩ 6.0 mΩ 6.5 mΩ 9.0 mΩ 25 mΩ 40 mΩ 375 mΩ 4.0 Ω		P
Earth Contunity and Bond Current at 50Hz	100 mA 200 mA 200 mA to 500 mA 500 mA to 4 A 4 A to 8 A 8 A to 12 A 12 A to 25 A	4.9 mA 5.7 mA 8.5 mA 80 mA 115 mA 150 mA 270 mA		P
Earth Coninuity Current DC	10 mA to 100 mA 100 mA to 300 mA	1.3 mA 3.0 mA		
Leakage Current at 50Hz	0 mA to 1 mA 1 mA to 10 mA 10 mA to 20 mA	3.0 µA 8.0 µA 50 µA		P
Insulation Resistance DC *See DC Resistance Insulation Testers*				P
Insulation Resistance Test Voltage	50 V 100 V 150 V 200 V 250 V 500 V 1000 V	0.8 V 1.1 V 1.4 V 1.7 V 2.0 V 3.5 V 6.5 V		P
Earth Continuity Resistance *See DC Resistance Contunity Testers*				
Flash Test Voltage at 50 Hz	1 kV to 1.5 kV (Class 1) 1.5 kV to 3 kV (Class 2)	45 V 80 V		P
Flash Test Current	0.67 mA to 1 mA (Class 1) 0.34 mA to 1 mA (Class 2)	40 µA 40 µA		P
Load at 50Hz	49 VA to 7.5 kVA	0.20 VA		P
END				